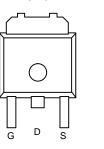
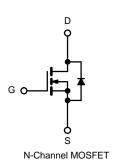


N-Channel 80 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω) Max.	I _D (A)	Q _g (Typ.)		
	0.0055 at V _{GS} = 10 V	75 ^a			
80	0.0088 at V _{GS} = 6.0 V	65 ^a	17.1 nC		
	0.0115 at V _{GS} = 5.0 V	54			

TO-252





Top View

FEATURES

- TrenchFET[®] Power MOSFET
- 100 % $\rm R_g$ and UIS Tested

APPLICATIONS

- Primary Side Switching
- Synchronous Rectification
- DC/AC Inverters
- LED Backlighting



ABSOLUTE MAXIMUM RATINGS (7	T _A = 25 °C, unless	otherwise note	ed)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	80	v	
Gate-Source Voltage		V _{GS}	± 20	v
	T _C = 25 °C		75 ^a	
Continuous Drain Current (T. 150 °C)	T _C = 70 °C	Γ. Γ	62.7	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	28.6 ^{b, c}	
	T _A = 70 °C		24.9 ^{b, c}	A
Pulsed Drain Current (t = 100 µs)		I _{DM}	150	A .
Continuous Courses Drain Diado Current	T _C = 25 °C		75a	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	4.5 ^{b, c}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	30	
Single Pulse Avalanche Energy	L = 0.1 MH	E _{AS}	45	mJ
	T _C = 25 °C		62.5	
Movimum Dower Dissignation	T _C = 70 °C		40	14/
Maximum Power Dissipation	T _A = 25 °C	P _D –	5 ^{b, c}	W
	T _A = 70 °C		3.2 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C
Soldering Recommendations (Peak Temperature		260		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	20	25	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.5	2.0	0/00

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

- d. The TO-220 is a leadless package. The end of the lead terminal is exposed
- copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 70 °C/W.

NCE7560K

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	www	v.VBsemi.tw

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						_	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$	80			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	L 050 A		37		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.1			
Gate-Source Threshold Voltage	V _{GS(th})	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	2.5		4.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zaura Oata Malta na Duaira Orumant	I _{DSS}	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$			1	_	
Zero Gate Voltage Drain Current		$V_{DS} = 80 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 ^{\circ}\text{C}$			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	30			А	
		V _{GS} = 10 V, I _D = 20 A		0.0050			
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 6 V, I _D = 15 A		0.0070		Ω	
		$V_{GS} = 5.0 \text{ V}, \text{ I}_{D} = 10 \text{ A}$		0.0087			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 20 A		60		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1855			
Output Capacitance	C _{oss}	V _{DS} = 40 V, V _{GS} = 0 V, f = 1 MHz		950		pF	
Reverse Transfer Capacitance	C _{rss}			76			
	Qg	$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		35.5	54		
Total Gate Charge		$V_{DS} = 40 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$		22	33		
				17.1	26	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 40 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		5.3			
Gate-Drain Charge	Q _{gd}			7.3			
Output Charge	Q _{oss}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$		57	86		
Gate Resistance	Rg	f = 1 MHz	0.5	1.3	2	Ω	
Turn-On Delay Time	t _{d(on)}			12	24	-	
Rise Time	t _r	$V_{DD} = 40 \text{ V}, \text{ R}_{L} = 4 \Omega$		8	16		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 10$ Å, $V_{GEN} = 10$ V, $R_g = 1 \Omega$		32	64		
Fall Time	t _f			7	14	1	
Turn-On Delay Time	t _{d(on)}			14	28	ns	
Rise Time	tr	V_{DD} = 40 V, R_L = 4 Ω		11	22	1	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 10$ Å, $V_{GEN} = 6.0$ V, $R_g = 1$ Ω		30	60		
Fall Time	t _f			8	16		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			75	۸	
Pulse Diode Forward Current (t = $100 \ \mu s$)	I _{SM}				150	A	
Body Diode Voltage	V _{SD}	I _S = 5 A		0.76	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			38	75	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			36	70	nC	
Reverse Recovery Fall Time	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 \text{ °C}$			19			
Reverse Recovery Rise Time	t _b			19		ns	

Notes

a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

NCE7560K



= - 55 °C

8

48

V_{GS} = 4.5 V

125

150

100

60

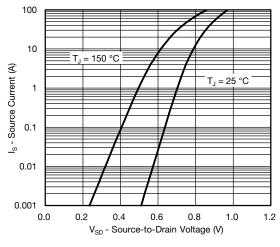
10

100 120 = 10 V thru 6 V 100 80 I_D - Drain Current (A) V_{GS} =5 V I_D - Drain Current (A) 80 60 T_c = 25 °C 60 40 40 20 = 125 20 °C $V_{GS} = 4 V$ $V_{GS} = 3 V$ 0 0 0.0 2 4 6 0.0 1.0 2.0 3.0 4.0 5.0 V_{GS} - Gate-to-Source Voltage (V) V_{DS} - Drain-to-Source Voltage (V) **Output Characteristics Transfer Characteristics** 0.0150 3500 2800 0.0130 $R_{DS(on)}$ - On-Resistance ($\Omega)$ C - Capacitance (pF) Coss 2100 0.0110 V_{GS} =5.0 V 1400 0.0090 V_{GS} = 6.0 V 700 0.0070 C_{rss} V_{GS} = 10 V 0.0050 0 0 12 24 36 0 40 60 20 80 100 V_{DS} - Drain-to-Source Voltage (V) I_D - Drain Current (A) **On-Resistance vs. Drain Current** Capacitance 2.0 10 $I_{\rm D} = 10 \,{\rm A}$ $V_{GS} = 10 V$ I_D = 20 A V_{GS} - Gate-to-Source Voltage (V) 8 1.7 $V_{DS} = 40 V$ R_{DS(on)} - On-Resistance (Normalized) 1.1 7.1 6 $V_{DS} = 20 V$ $V_{DS} = 60 V$ 4 0.8 2 0.5 0 16 24 Q_g - Total Gate Charge (nC) 0 25 50 75 100 T_J - Junction Temperature (°C) 0 8 32 40 - 50 - 25 **Gate Charge On-Resistance vs. Junction Temperature**

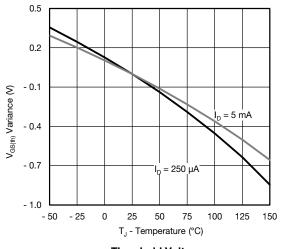
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



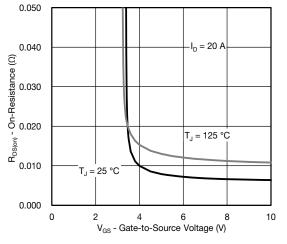
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



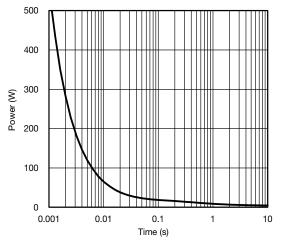
Source-Drain Diode Forward Voltage



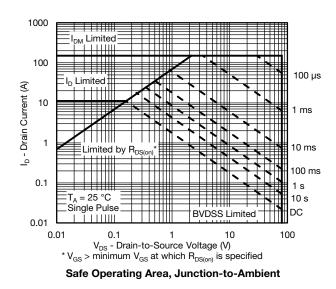




On-Resistance vs. Gate-to-Source Voltage

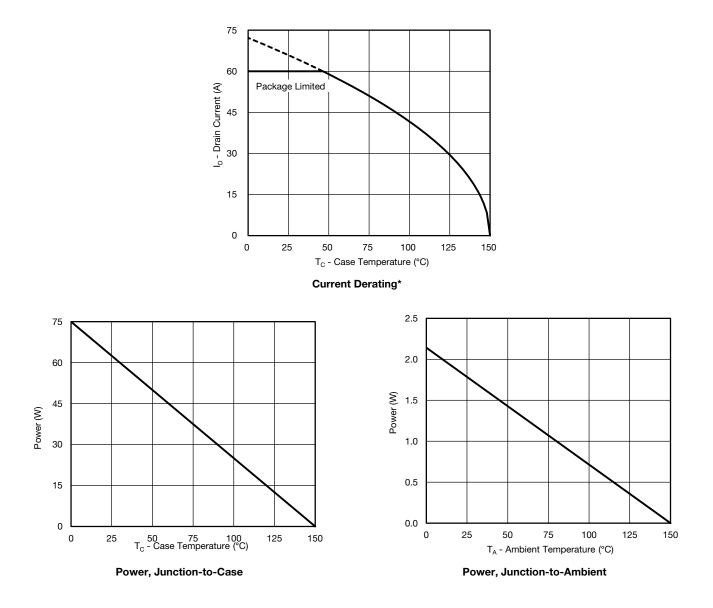


Single Pulse Power, Junction-to-Ambient





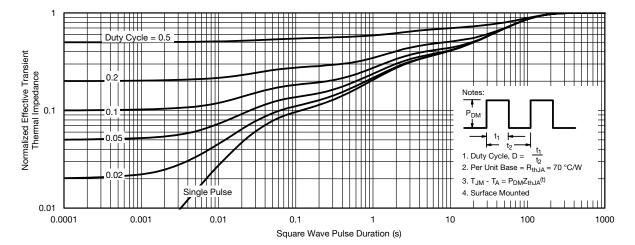
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



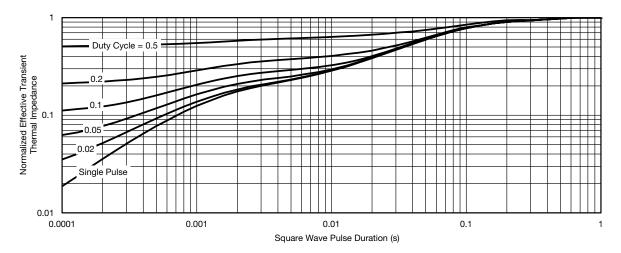
* The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



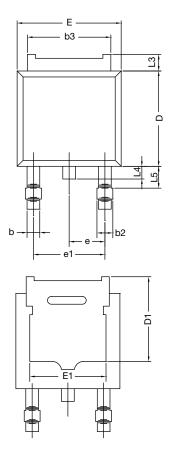
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



TO-252AA CASE OUTLINE





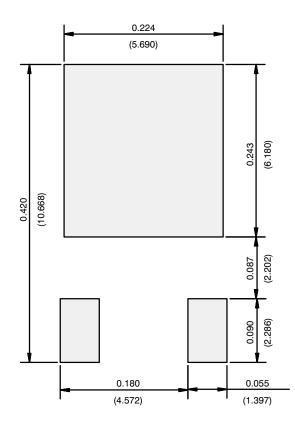
	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

Note

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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